Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/817,095	HWANG ET AL.
Examiner	Art Unit
Huy D. Nguyen	2681

SEARCHED							
Cla	ass	Subclass	Date		Examiner		
4	55	560	10/14/2005		HN		
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INTERFERENCE SEARCHED							
Class	Subclass	Date	Examiner				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)						
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East (USPAT, US-PGPUB, JPO, EPO, DERWENT) - See search history printout.	10/14/2005	HN				
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